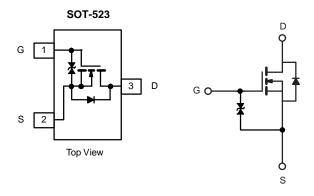


# N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>c</sup>	Q <sub>g</sub> (TYP.)			
20	0.273 at V <sub>GS</sub> = 4.5 V	1.6	1.4 nC			
20	0.399 at V <sub>GS</sub> = 2.5 V	1.3	1.4110			



#### **FEATURES**

- DT-Trench Power MOSFET
- 100 % R<sub>a</sub> tested
- Gate-Source ESD Protected



RoHS

#### **APPLICATIONS**

- Smart phones, tablet PC's
  - DC/DC converters
    - Boost converters
  - Load switch, OVP switch

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	20	V	
Gate-Source Voltage		V <sub>GS</sub>	± 8	v
	T <sub>C</sub> = 25 °C		1.8	
Continuous Prain Current (T 150 °C)	T <sub>C</sub> = 70 °C		1.5	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	1.5 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		1.2 <sup>a, b</sup>	Α
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	6	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		0.4	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.3	
	T <sub>C</sub> = 25 °C		0.5	
Maniana Dania Dissipation	T <sub>C</sub> = 70 °C		0.3	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.4 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C		0.3 <sup>a, b</sup>	
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak Temperature)		260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient a, d	t ≤ 10 s	R <sub>thJA</sub>	250	300	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	225	270	]	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on  $T_C = 25$  °C.
- d. Maximum under steady state conditions is 360 °C/W.





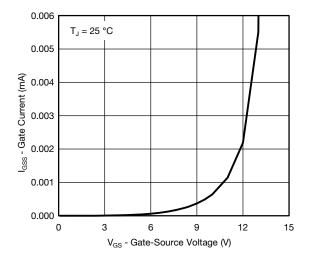
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static		,	L	l	L	ı	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A	-	32	-	>//00	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-3	-	mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.5	-	1.0	V	
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 4.5 V	-	-	0.1		
Gate-Source Leakage	$I_{GSS}$	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 12 V		-	± 20		
Zana Oaka Walliana Buria Oanaal		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	-	-	0.1	- μA -	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	2	-	-	Α	
	_	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1 A	-	0.273	0.355		
Drain-Source On-State Resistance a	$R_{DS(on)}$	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 0.5 A	-	0.399	0.450	Ω	
Forward Transconductance a	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.4 A	-	5	-	S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		-	105	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	23	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	<del></del> 1		11	-		
Total Cata Charge	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 1.4 \text{ A}$	-	2.7	4.1		
Total Gate Charge		$Q_{gs}$ $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.4 \text{ A}$	-	1.4	2.1		
Gate-Source Charge	$Q_{gs}$		-	0.3	-		
Gate-Drain Charge	$Q_{gd}$		-	0.5	-		
Gate Resistance	$R_g$	f = 1 MHz	1.4	7	14	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	2	4		
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 13.6 \Omega$	-	9	18		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1.1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	8	16		
Fall Time	t <sub>f</sub>		-	8	16		
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16	ns	
Rise Time	t <sub>r</sub>	1 11 A V A F V D 1 O		13	20	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			15	23		
Fall Time	t <sub>f</sub>		-	6	12		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	0.4	Δ.	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>		-	-	6	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>F</sub> = 1.1 A	-	0.8	1.2	V	
Body Diode Reverse Recovery Time t <sub>rr</sub>			-	8	16	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	-	3	6	nC	
Reverse Recovery Fall Time	ta	$I_F = 1.1 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	5	-		
Reverse Recovery Rise Time	t <sub>b</sub>	1	-	3	-	ns	

### Notes

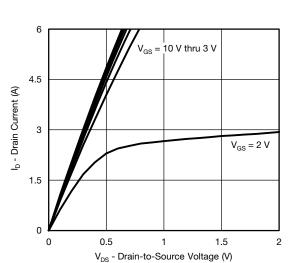
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

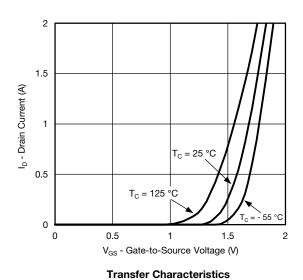




Gate Source Voltage vs. Gate Current

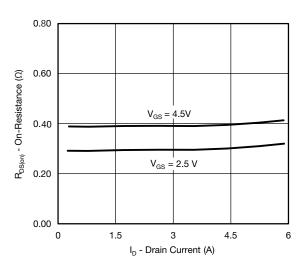


**Output Characteristics** 

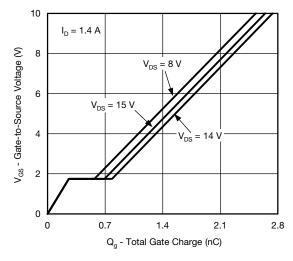


10<sup>-3</sup>
10<sup>-4</sup>
10<sup>-5</sup>
10<sup>-6</sup>
10<sup>-6</sup>
10<sup>-8</sup>
10<sup>-9</sup>
0
5
10
10
15
V<sub>GS</sub> - Gate-to-Source Voltage (V)

**Gate Source Voltage vs. Gate Current** 

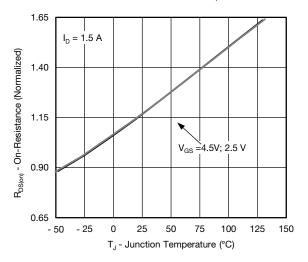


On-Resistance vs. Drain Current

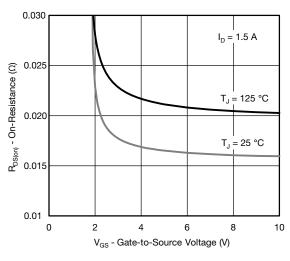


**Gate Charge** 

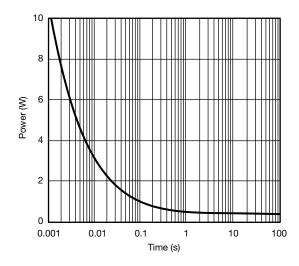




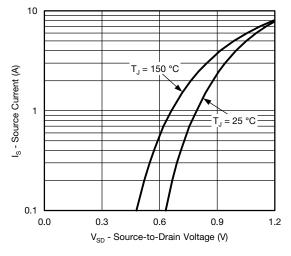
On-Resistance vs. Junction Temperature



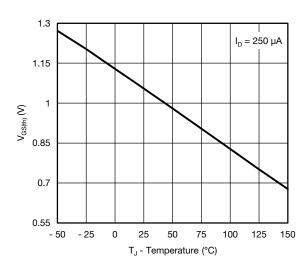
On-Resistance vs. Gate-to-Source Voltage



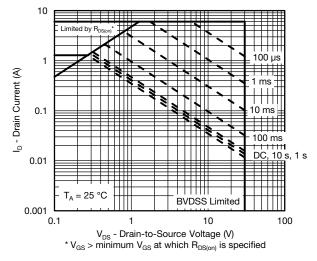
Single Pulse Power, Junction-to-Ambient



Source-Drain Diode Forward Voltage

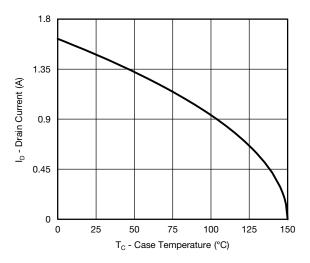


Threshold Voltage

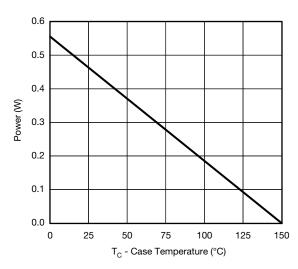


Safe Operating Area, Junction-to-Ambient

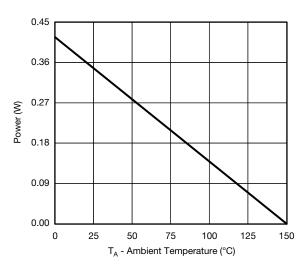




#### **Current Derating\***



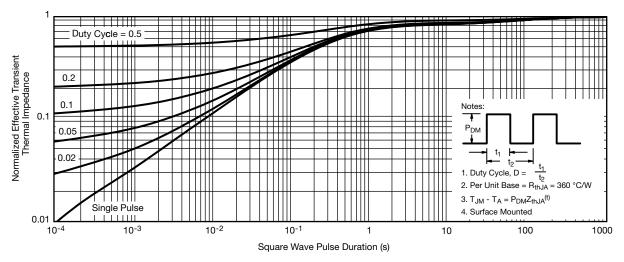




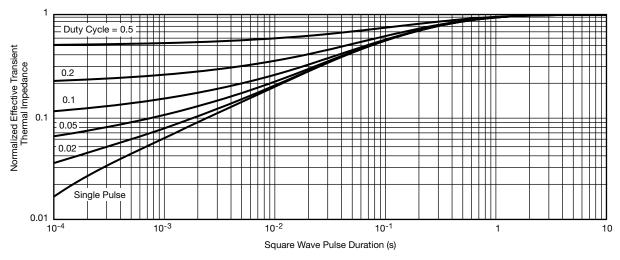
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





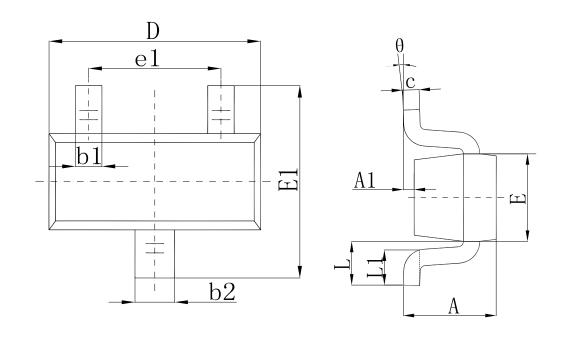
Normalized Thermal Transient Impedance, Junction-to-Ambient

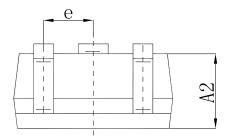


Normalized Thermal Transient Impedance, Junction-to-Foot



### SOT-523 PACKAGE OUTLINE





COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

0 1 1		Dim in m	ım		
Symbol	Min	Nor	Max		
A	0. 70	0.80	0. 90		
A1	0.00	0.05	0. 10		
A2	0. 70	0. 75	0.80		
b1	0. 15	0. 22	0. 29		
b2	0. 25	0.32	0. 39		
С	0. 10	0. 15	0. 20		
D	1.50	1.60	1. 70		
E	1. 45	1.60	1. 75		
E1	0. 70	0.80	0. 90		
e	0. 500TPY.				
e1	0. 90	1.00	1. 10		
L	0. 26	0.36	0. 46		
L1	0. 400REF.				
θ	0°	4°	8°		





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